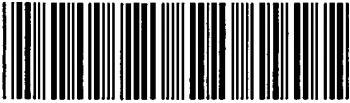

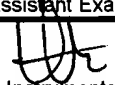


Issue Classification 	Application/Control No. 09/730,340	Applicant(s)/Patent under Reexamination OSAKABE ET AL.
	Examiner Devona E. Faulk	Art Unit 2615

ISSUE CLASSIFICATION												
ORIGINAL					INTERNATIONAL CLASSIFICATION							
CLASS		SUBCLASS			CLAIMED				NON-CLAIMED			
700		94			G	6	F	17	/00			/
CROSS REFERENCES					H	4	J	3	/16			/
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				H	4	J	3	/24			/
370	471	474			G	6	F	15	/16			/
709	236				G	6	F	3	/00			/
710	30								/			/
									/			/
									/			/

Devona E. Faulk 9/26/2006 (Assistant Examiner) (Date)	 VIVIAN CHIN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner) (Date)	Total Claims Allowed: 4
 (Legal Instruments Examiner) (Date)	O.G. Print Claim(s) 11	O.G. Print Fig. 15A

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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